

**Search Notes**

Application/Control No.

10/768,578

Examiner

Drew E. Becker

Applicant(s)/Patent under  
Reexamination

CZARK ET AL.

Art Unit

1794

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR